

<b>Notice of References Cited</b>	Application/Control No. 10/551,312		Applicant(s)/Patent Under Reexamination DU ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,079,509 B2	07-2006	Belcea, John M.	370/330
*	B	US-2002/0085520 A1	07-2002	Sydon et al.	370/335
*	C	US-6,047,178 A	04-2000	Frlan, Edward	455/423
*	D	US-5,995,844 A	11-1999	Fukuda, Kunio	455/462
*	E	US-6,415,146 B1	07-2002	Capece, Christopher J.	455/517
*	F	US-6,807,165 B2	10-2004	Belcea, John M.	370/347
*	G	US-5,636,243 A	06-1997	Tanaka, Syoichi	375/219
*	H	US-2003/0092452 A1	05-2003	Youngs et al.	455/461
*	I	US-5,423,055 A	06-1995	Diaz et al.	455/15
*	J	US-6,459,690 B1	10-2002	Le Strat et al.	370/332
*	K	US-7,082,108 B2	07-2006	Hwang et al.	370/311
*	L	US-6,580,704 B1	06-2003	Wellig et al.	370/338
*	M	US-2006/0258382 A1	11-2006	Zhang et al.	455/501

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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